

## **Notice of References Cited**

	<u></u>	
Application/Control No.	Applicant(s)/Patent Under	
09/800,684	Reexamination BAKER ET AL.	
Examiner	Art Unit	
Lee Khuona	2665 Page 1 of 1	

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,421,346	07-2002	Itoh et al.	370/395.7
	В	US-5,949,782	09-1999	Wells, David	370/395.2
	C~-	-US-6,308,217	10-2001	Sasagawa, Yasushi	709/236
	D	US-6,009,097	12-1999	Han, Yih-Wu	370/395.52
	Е	US-			
	F	US-	_		
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					,
	s					
	, Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.